ELETTRA 2.0 Workshop on Optical Diagnostics for Low-Emittance Storage Rings

Report of Contributions

Welcome

Contribution ID: 1

Type: not specified

Welcome

Wednesday 23 March 2022 09:00 (10 minutes)

Presenter: FERIANIS, Mario (Elettra)

Elettra 2.0 & its diagnostics

Contribution ID: 2

Type: not specified

Elettra 2.0 & its diagnostics

Wednesday 23 March 2022 09:10 (30 minutes)

Brief description of new machine and desired Optical Diagnostics

Presenter: BASSANESE, Silvano (Elettra)

Beam size monitoring at SLS (2.0)

Contribution ID: 3

Type: not specified

Beam size monitoring at SLS (2.0)

Wednesday 23 March 2022 11:30 (30 minutes)

Currently at the SLS, visible light is used to measure the vertical beam size using the pi-polarization technique.

At SLS 2.0, this is not going to meet the requirements. So we looked at other possibilities and discovered other challenges.

This presentation invites you to discuss "the good, the bad, and the ugly" of the proposed solution.

Presenter: OZKAN LOCH, Cigdem (PSI - Paul Scherrer Institut)

ELETTRA 2.0 W ··· / Report of Contributions

An X-ray beam property analyzer …

Contribution ID: 4

Type: not specified

An X-ray beam property analyzer for next generation light sources

Wednesday 23 March 2022 12:00 (30 minutes)

SLS

Presenter: SAMADI, Nazanin (PSI - Paul Scherrer Institut)

Emittance diagnostics at ESRF- ···

Contribution ID: 5

Type: not specified

Emittance diagnostics at ESRF-EBS using the X-ray Pinhole Camera

Thursday 24 March 2022 09:00 (30 minutes)

Presenter: EWALD, Friederike (ESRF)

Beam Profile Measurements using …

Contribution ID: 6

Type: not specified

Beam Profile Measurements using (Visible) Synchrotron Radiation Interferometry

Wednesday 23 March 2022 10:10 (30 minutes)

Presenter: TORINO, Laura (ALBA-CELLS)

X-ray Emittance Monitors at ALBA

Contribution ID: 7

Type: not specified

X-ray Emittance Monitors at ALBA

Wednesday 23 March 2022 09:40 (30 minutes)

Presenter: IRISO, Ubaldo (ALBA)

Integral or Bunch Selective or ev ...

Contribution ID: 8

Type: not specified

Integral or Bunch Selective or even 2D: Interferometric Beam Profiling @ BESSY II

Wednesday 23 March 2022 12:30 (30 minutes)

Optical beam diagnostics at BESSY II is being upgraded towards bunch selective measurements at three new beamlines for visible light and THz using two bending magnets. Developments are focused on several directions

+ time resolution

+ spatial resolution

+ correlated 2D capabilities (for "time" vs. "x" or alternatively "y" as well as for "x" vs. "y")

+ data acquisition time / illumination rate

The current status will be discussed including lessons that we have learned

Presenter: SCHIWIETZ, Gregor

Monitoring beam emittance and b $\, \cdots \,$

Contribution ID: 9

Type: not specified

Monitoring beam emittance and beam relative energy spread at MAX IV

Wednesday 23 March 2022 11:00 (30 minutes)

Presenter: ANDERSSON, Ake (MAX IV)

Soleil

Contribution ID: 10

Type: not specified

Soleil

Thursday 24 March 2022 09:30 (30 minutes)

Presenter: LABAT, Marie (SOLEIL)

Emittance Diagnostics at PETRA IV

Contribution ID: 11

Type: not specified

Emittance Diagnostics at PETRA IV

Thursday 24 March 2022 10:00 (30 minutes)

Presenters: KUBE, Gero (DESY); MARONGIU, Marco (DESY)

Closing day 1

Contribution ID: 12

Type: not specified

Closing day 1

Wednesday 23 March 2022 13:00 (10 minutes)

Presenter: FERIANIS, Mario (Elettra)